Instruction Manual

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P6022 CURRENT PROBE AND TERMINATION

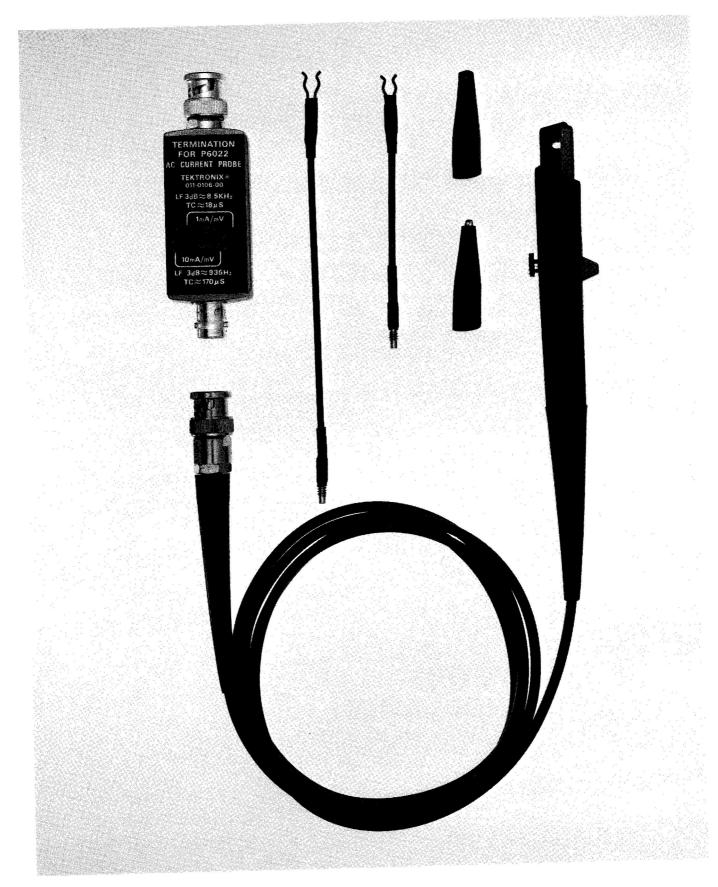


Fig. 1-1. P6022 Current Probe and Termination.

SECTION 1 SPECIFICATION

Introduction

The Tektronix P6022 5 foot and 9 foot Current Probes are designed to measure alternating current waveforms. These probes, used with current devices such as the Type 134 Current Probe Amplifier, 7A14 Current Probe Amplifier plug-in, or the P6022 Passive Termination permit a current waveform to be viewed and measured on the oscilloscope. This instruction manual deals primarily with the P6022 Current Probe as used with the Termination. For information concerning use with the current probe amplifiers, refer to the appropriate current probe amplifier instruction manual.

The specifications pertain to the P6022 Current Probe with Termination.

ELECTRICAL CHARACTERISTICS

Characteristic	Performance
Step Response	
Aberrations (Probe and Termination only)	
1 mA/mV	+3%, -3% or less, total of 4% or less peak to peak within 25 nanoseconds of step; +1%, -1% or less, total of 2% or less peak to peak thereafter.
10 mA/mV	+4%, -4% or less, total not to exceed 6% (5 foot probe) or 8% (9 foot probe) peak to peak within 25 nanoseconds of step; +1%, -1% or less, total not to exceed 2% peak to peak thereafter.
Risetime (Probe and Termination only)	
1 mA/mV	2.5 nanoseconds or less
10 mA/mV	2.2 nanoseconds or less
Risetime (with Type 454 test oscilloscope)	
1 mA/mV	3.5 nanoseconds or less

ELECTRICAL CHARACTERISTICS (cont)

Characteristic	Performance				
10 mA/mV	2.9 nanoseconds or less				
Tilt					
1 mA/mV	4% or less within one microsecond of step				
10 mA/mV	4% or less within ten microsecond of step				
Sensitivity	One milliampere or ten millampere for each millivolt at oscilloscope input, selected by slide switch.				
Accuracy	Within ±3%				
Bandwidth (with Type 454 test oscilloscope)					
1 mA/mV	8.5 kilohertz or less to 100 megahertz or more				
10 mA/mV	935 hertz or less to 120 megahertz or more				
Maximum CW Current	6 amperes peak to peak sinewave between 10 kHz and 10 MHz at 1 mA/mV; between 3 kHz and 10 MHz at 10 mA/mV (see Fig. 1-2)				
Maximum Pulse Current	100 amperes peak, not to exceed 9 ampere-microseconds or 2 amperes RMS. Ampere-second products in excess of 9 A-\mus reduces probe output to zero due to core saturation.				
Maximum Voltage	600 volts (DC + peak AC)				
Maximum DC Saturation	200 milliamperes				
Delay Time	\approx 9 nanoseconds (5 foot probe) or \approx 15 nanoseconds (9 foot probe) with termination.				
Insertion Impedance	0.03 Ω or less at 1 MHz, increasing to 0.2 Ω or less at 120 MHz.				

ENVIRONMENTAL CHARACTERISTICS

Characteristic	Information				
Temperature					
Storage	-40°C to +65°C				
Operating	0°C to +50°C				
Altitude					
Storage	To 50,000 feet				
Operating	To 15,000 feet				
Vibration					
Operating	15 minutes along each axis at 0.015". Vary the frequency from 10 to 50 to 10 c/s in 1-minute cycles. Three minutes at any resonant point or at 50 c/s.				
Shock					
Nonoperating	30 g's, 1/2 sine, 11 microseconds duration, 2 shocks per axis. Total of 6 shocks.				

PHYSICAL CHARACTERISTICS

Characteristic	Information					
Dimensions						
Probe Body	≈0.6" H X 0.4" W X 6.0" L					
Probe Cable	57.5" L (5 foot cable), or 105.5" L (9 foot cable)					
Termination	≈0.9" H X 1.0" W X 3.5" L					
Weight						
P6022 Probe and Cable	≈2.5 oz.					
Termination	≈2.0 oz.					
Finish						
Termination	Plated metal castings with gray plastic covers.					

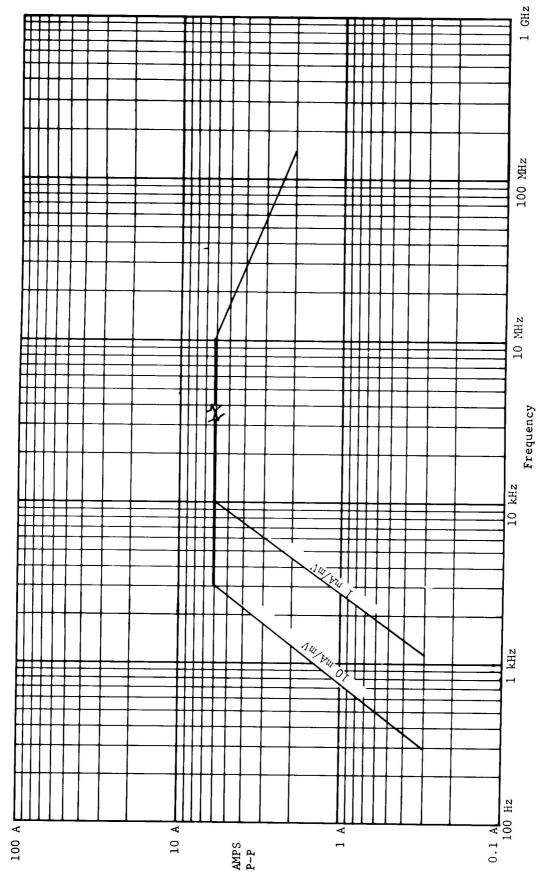


Fig. 1-2. P6022/Termination Input Current vs Frequency Derating

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General

The P6022 Current Probe, when mination and an oscilloscope, prouring alternating current wavefor the P6022, the operation and capab be known. This section gives first-tininformation and some basic applications.

Installation

When the P6022 Current Probe i tion, an oscilloscope having a ve pedance of one megohm is requir component lead. Also, less noise or spurious signal interference will be seen when the probe is connected near ground.

High Currents

When measuring high currents, do not leave the current probe clamped around the conductor while disconnecting the probe cable from the termination. With the probe cable unterminated under this condition, a high voltage is developed in the secondary winding which may damage the current probe transformer.

Increasing the Sensitivity

The current sensitivity of the P6022 Current Probe and Termination can be increased by increasing the number of turns passing through the core of the probe. For example, if the conductor is looped through the probe two times, a two-turn primary winding is formed, increasing the secondary current by a factor of two. (The ratio of current in a transformer is inversely proportional to the turns ratio.) With the P6022 Termination switch set to 1 mA/mV and the oscilloscope vertical deflection factor set to 10 mV/div, the

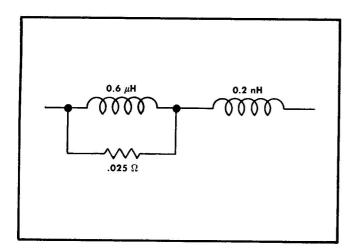


Fig. 2-3. Insertion Impedance of the P6022 Current Probe.

deflection factor would actually be reduced by a factor of two, to $.5\,\text{mA/div}$.

Remember, however, that the impedance reflected into the primary (circuit being measured) from the secondary (probe winding) varies as the square of the number of primary turns. When observing high-frequency current waveforms or fast-rise pulses, the inductance added to the primary circuit by the additional turns may be significant.

Insertion Impedance

The insertion impedance of the current probe is the equivalent circuit which is placed in the circuit under test when the probe is clamped around a conductor. When observing fast-rise signals, this should be taken into consideration. Fig. 2-3 illustrates the approximate insertion impedance of the P6022 Current Probe.

Probe Shielding

The current probe is shielded to minimize the effect of external magnetic fields. However, strong fields may interfere with a current signal being measured. If you suspect that an external field is interfering with your measurement, remove the probe from the conductor and place it in the vicinity of the original measurement. If you obtain appreciable deflection, attempt to measure the conductor current at another point, away from the magnetic field source.

If current measurements must be made in the presence of a strong external field, the external field interference may be minimized by the use of two current probes and a differential-input oscilloscope. Both current probes must be connected to the oscilloscope inputs in the same manner, using P6022 Terminations.

With both probes connected to a differential-input oscilloscope, clamp one probe around the conductor in which the current is to be measured, and place the other probe near the first, with the slider closed. By setting the oscilloscope controls for common-mode rejection, the undesirable current signal induced in one probe can be minimized by the induced current in a second probe. Adjust the positions of the probes for best results. Complete cancellation of the undesirable signal may be difficult to obtain, due to probe and termination differences.

SECTION 3 CIRCUIT DESCRIPTION

Introduction

This section of the manual contains descriptions of the circuitry in the P6022 Current Probe and Termination. Complete circuit schematics are given in the Diagrams section. Refer to these diagrams throughout the following circuit description.

Current Probe

The P6022 Current Probe consists of a current transformer mounted in the nose of the case, an impedance matching network, and a switch to disconnect the transformer shield from ground.

The transformer contains a two-section U-shaped ferrite core. One section is stationary, the other is mechanically movable to permit closing the core around the conductor being measured. The conductor under test forms a one-turn primary winding for the transformer; the windings around the stationary portion of the core form the secondary windings. Paralleled windings in the secondary assure a fast step response. The circuitry between the transformer and the coaxial cable corrects any difference in level between the pulses induced in the paralleled windings of the secondary, and matches the balanced probe winding to the cable.

As indicated on the probe body, the turns ratio of the P6022 Current Probe is 50:1. This refers to the number of windings in the secondary of the probe transformer. The two turns ratios manufactured by Tektronix, Inc. are 50:1 and 125:1. Due to the comparatively low inductance in the secondary of the 50:1 probe, this probe operates at a higher frequency range than the 125:1 probe.

The probe transformer is shielded to eliminate interference from outside signals. To eliminate the possibility of shorting this shield to the conductor being measured when connecting or removing the probe, a slide switch, SW20, disconnects the ground from the shield when the slide portion of the probe is open.

Termination

The P6022 Termination consists of a 62.5-ohm impedance matching network to terminate the coaxial cable, and a voltage divider which is switched in by a slide switch, changing the sensitivity by a factor of ten. With the slide switch in the 1 mA/mV position, a ten milliampere current signal in the conductor under test induces a ten millivolt signal at the output of the termination when the termination is connected to a one-megohm input oscilloscope. In the 10 mA/mV position, the signal is attenuated to produce a one millivolt signal at the output.

SECTION 4 MAINTENANCE

Introduction

The information in this section will be helpful in removing and replacing parts in the P6022 Current Probe and Termination. When parts are replaced in either the probe or termination, it will be necessary to check the performance to determine if recalibration is needed. Refer to Section 5 of this manual for test equipment required to check the operation of the probe and termination.

Cleaning the Current Probe

The current probe should be taken apart and cleaned periodically, depending upon local conditions. Use a soft bristle brush to dislodge the dust and wipe clean with a soft cloth. If a persistent coating of dirt remains, it can be removed by washing the plastic portions of the probe in warm water with some liquid detergent added. Allow the parts to air dry thoroughly, or wipe dry with a lint-free cloth. Apply a light coating of lubricant to the contact areas of the spring.

While cleaning the probe, make a visual check of the probe parts. Look for any excessive wear of the slide parts which may cause improper operation later on. Dirty or worn mating surfaces between the transformer and the lid will degrade the low-frequency response. Clean these surfaces if necessary.

NOTE

Do not use any organic solvents to clean the probe.

Probe Disassembly

- 1. Hold the probe in a horizontal position with the slider up.
- 2. Move the strain relief boot back over the cable.
- 3. Carefully lift the upper half of the probe body slightly at the cable end and remove from the assembly.
 - 4. Remove the small metal ball from the detent in the slider.
 - 5. Remove the slider spring and spring holder from the slider.
- Remove the slider and the top of the transformer. Note the position of the movable portion of the transformer in the slider.
- 7. If further disassembly is required, the connection between the circuit board and the ground strap connector must be unsoldered. After this is done, lift the transformer, circuit board, and cable out of the probe body as a unit. The P6022 Current Probe is shown disassembled in the Mechanical Parts List section of this manual.

8. Reassemble the probe, reversing the above procedure.

Repairing the Current Probe

To make repairs inside the probe body, take the probe apart as described previously. Observe positioning and length of soldered leads for re-assembly. To remove the current transformer, unsolder the leads from the circuit board. When replacing the current transformer, replace the entire assembly, including the core mounted in the slide. The complete transformer assembly is matched at the factory before it is shipped.

Repairing the Termination

Replacement of Connectors

- Remove the plastic snap-on cover from the front of the termination. This can be done either with the fingers or by inserting a small screwdriver between the cover and the termination, near the part number, and turning slightly.
- Using a heat sink, unsolder the lead(s) from the defective connector.
 - 3. Unscrew the defective connnector and remove.
- 4. Replace the connector by reversing the above procedure. When replacing the front cover, align the switch with the slider in the front cover.

Removal of Circuit Board

- 1. Remove the plastic snap-on covers from the front and back of the termination.
 - 2. Using a heat sink, unsolder the leads from the connectors.
 - 3. Remove the two screws from the back of the circuit board.
 - 4. Remove the circuit board from the termination.



If making repairs to the circuit board, do not apply excessive heat, as the bond between the circuit board and the conductive material may be damaged.

5. Replace the circuit board by reversing the above procedure. When replacing the front cover, align the switch with the slider in the front cover.

SECTION 5 PERFORMANCE CHECK/RECALIBRATION

Introduction

This section provides procedures to be used in checking performance or in calibrating the P6022 Current Probe and Termination. Limits and tolerances in this section are given as calibration guides and are not necessarily instrument specifications.

To ensure measurement assuracy, check the performance of the probe and termination whenever changing from one test oscilloscope to another, especially when changing input capacitance, and recalibrate if necessary. Check the calibration of the probe and termination every 1000 hours of operation, or every six months if used infrequently. Before calibration, thoroughly clean and inspect the probe as outlined in the Maintenance section. Dirty or worn mating surfaces between the transformer and the lid will degrade the low-frequency response. Clean these surfaces if necessary.

The features provided by this section are:

Index. The Short-Form Procedure lists the step numbers and titles of the complete Performance Check/Calibration Procedure.

Calibration Record. The Short-Form Procedure can be reproduced and used as a permanent record of instrument calibration. Spaces are provided to record performance data for this instrument or to check off steps as they are completed.

Abridged Calibration Procedure. The Short-Form Procedure lists the adjustments necessary for each step and/or the applicable tolerance for correct calibration. The experienced calibrator who is familiar with the calibration of this instrument can use this procedure to facilitate checking or calibrating this instrument.

Performance Check. The Calibration Procedure can be used as a performance checkout procedure by completing all portions except the ADJUST—part of a step. This checks the probe and termination to the original performance standards without removing the termination cover or making internal adjustments.

Complete Calibration. Completion of each step in the Calibration Procedure checks the probe and termination to the original performance standards and gives the procedure to set each adjustment to its optimum setting. Where possible, instrument performance is checked before an adjustment is made. For best overall instrument performance make each adjustment to the exact setting even if the CHECK—is with the allowable tolerance.

EQUIPMENT REQUIRED

General

The following items are required for calibration of the P6022 Current Probe and Termination. Specifications given are the minimum necessary for accurate calibration. All test equipment is assumed to be correctly calibrated and operating withinn the given specifications. If equipment is substituted, it must meet or exceed the specifications of the recommended equipment.

For the quickest and most accurate calibration, special Tektronix calibration fixtures are used where necessary. These special calibration fixtures are available from Tektronix, Inc. Order by part number through your local Tektronix Field Office or representative.

Test Equipment

- 1. Test oscilloscope. Bandwidth, DC to 150 megahertz; deflection factor, 5 mV/div to 20 mV/div. Tektronix Type 454 recommended.
- 2. Pulse generator. Risetime, 0.25 nanosecond, amplitude, 0 to 50 volts into 50 ohms. Tektronix Type 109 recommended.
- 3. Low-frequency constant amplitude signal generator. Frequency, 500 hertz to 50 kilohertz; output amplitude, variable from less than 3.5 volts to above 4 volts into 50 ohms; amplitude regulation accuracy, constant within 3% of reference at 50 kilohertz as output frequency changes. For example, General Radio 1310-A Oscillator.
- 4. Transmission line. Risetime, 0.1 nanosecond; delay, 60 nanoseconds. Tektronix Type 113 Delay Cable recommended.

Accessories

- 5. Cable (two). Impedance, 50 ohms; electrical length, 5 nano-seconds; connectors, GR. Tektronix Part No. 017-0502-00.
- 6. Attenuator (two). Impedance, 50 ohms; attenuation, $10\times$; connectors, GR. Tektronix Part No. 017-0078-00.
- 7. Attenuator. Impedance, 50 ohms; attenuation, 5×; connectors, GR. Tektronix Part No. 017-0079-00.
- 8. Termination. Impedance, 50 ohms; description, end-line; connector, GR. Tektronix Part No. 017-0081-00.
- 9. Termination. Impedance, 50 ohms; description, GR to BNC male. Tektronix Part No. 017-0083-00.
- 10. Adapter. Description, GR to BNC male. Tektronix Part No. 017-0064-00.
- 11. Adapter. Description, Dual banana plug to BNC female. Tektronix Part No. 103-0090-00.
- 12. Calibration Fixture. Description, 50 ohm terminating current loop; connector, GR. Tektronix Part No. 067-0559-00.
- 13. Viewing hood. Purpose, for viewing low-intensity displays on Type 454 test oscilloscope. Tektronix Part No. 016-0083-00.
- 14. Adjustment tool. Description, non-conducting screwdriver. Tektronix Part Nos. 003-0307-00 (handle), and 003-0334-00 (insert).

5-1 REV APR 1983

SHORT-FORM PROCEDURE

Type P6022 Probe and Termination, Date Code	- PROCEDURE			
Calibration date	PROCEDURE			
Calibrated by				
1. Check/Adjust Aberrations (C28, C29, R10) REQUIREMENT: 1 mA/mV aberrations within +3%, -3%, total of 4%; 10 mA/mV aberrations within +4%, -4%, total not to exceed 6% (5 foot probe), or 8% (9 foot probe). PERFORMANCE: Correct; incorrect (list exceptions);	General The following procedure is arranged so that the P6022 Current Probe and Termination can be calibrated with the least interaction of adjustments and reconnection of equipment. The equipment required for the entire procedure is shown in Fig. 5-1. Following the picture is a complete list of control settings for the test equipment.			
2. Check Risetime REQUIREMENT: 10 mA/mV risetime of ≤2.9 nano- seconds; 1 mA/mV risetime of ≤3.5 nanoseconds. PERFORMANCE: Correct; incorrect (list exceptions)	All waveforms shown in this procedure were taken with a Tektronix Oscilloscope Camera System. The following procedure uses the equipment listed under Test Equipment Required. If equipment is substituted, control settings or			
□ 3. Check Sensitivity REQUIREMENT: 1 mA/mV sensitivity of 80 millivolts, ±3%, at test oscilloscope input with 4-volt pulse applied to Calibration Fixture; 10 mA/mV sensitivity of 80 millivolts, ±3%, at test oscilloscope input with 40-volt pulse applied to Calibration Fixture. PERFORMANCE: Correct; incorrect (list	equipment setup may need to be altered to meet the requirements of the equipment used. Detailed operating instructions for the test equipment are not given in this procedure. If in doubt as to the correct operation of any of the test equipment, refer to the instruction manual for that unit.			
exceptions); incorrect (list	Preliminary Procedure for Complete Calibration			
4. Check Low Frequency Response REQUIREMENT: 1 mA/mV low frequency response of ≤8.5 kilohertz; 10 mA/mV low frequency re- sponse of ≤935 hertz. PERFORMANCE: Correct; incorrect (list exceptions);	When performing calibration, remove the top cover only from the P6022 Termination. The snap-on cover may be removed either the fingers or by placing a small screwdriver between the cover and the termination, near the part number, and turning slightly. The bottom cover must remain in place whenever the termination is in use.			
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PERFORMANCE CHECK/CALIBRATION

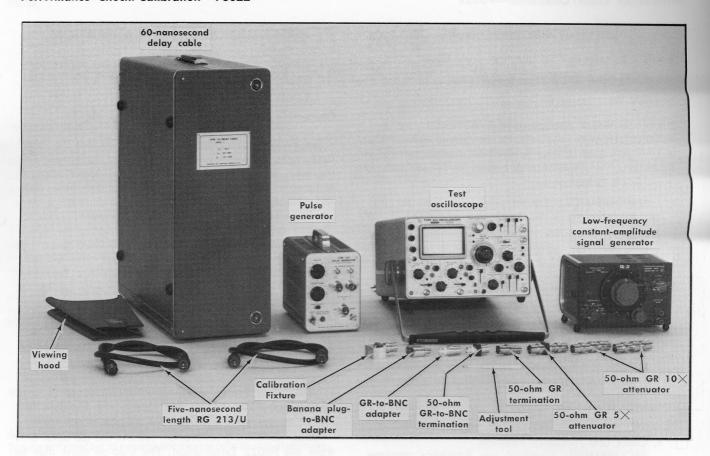


Fig. 5-1. Equipment required for calibration.

Control Settings

Test Oscilloscope

Intensity	Counterclockwise
Focus	Any position
Scale Illum	As desired
Bandwidth	Full
Ch 1 Volts/Div	20 mV
Variable Volts/Div	Cal
Mode	Ch 1
Trigger	Norm
Input Ch 1	DC
Time/Div	.05 μs
Horiz Display	A
Mag	Off
A Sweep Mode	Auto Trig
A Triggering	
Slope	+
Coupling	AC
Source	Int

Pulse Generator

Ampliude	5
Voltage Range	50
Pulse Polarity	+

1. Check/Adjust Aberrations

- a. Connect a 50-ohm GR termination to one of the pulse generator charge line connectors.
- b. Connect a five-nanosecond length of RG 213/U from the remaining charge line connector to one side of the 60nanosecond delay cable.
- c. Connect the Calibration Fixture to the pulse generator output connector.
- d. Connect the P6022 Termination to the input of the test oscilloscope. Set the termination slide switch to the 1 mA/ mV position.
- e. Connect the P6022 Probe to the termination. Clamp the probe around the conductor in the Calibration Fixture and move the slider all the way forward.
- f. Turn on the test equipment and adjust the triggering controls, Intensity, and pulse generator amplitude to obtain

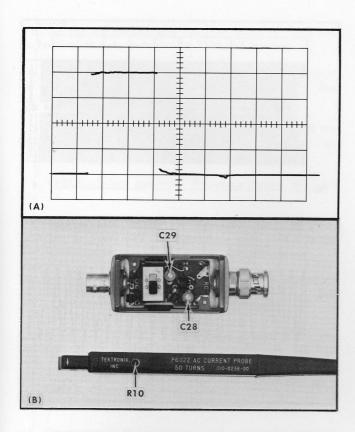


Fig. 5-2. P6022 aberrations, showing (A) four-division display of pulse generator output, and (B) location of three adjustments.

a four-division display. See Fig. 5-2A. (If necessary, use the viewing hood on the test oscilloscope.)

- g. CHECK—First 25 nanoseconds of step for aberrations within +3%, -3%, total of 4% peak to peak; +1% -1%, total of 2% peak to peak thereafter (not including the effects of the test oscilloscope).
- h. ADJUST—C28 and C29 (in the termination), then R10 (through the hole in the probe body), for aberrations within +3%, -3% total of 4% peak to peak during first 25 nanoseconds; +1%, -1%, total of 2% peak to peak thereafter (not including the effects of the test oscilloscope). See Fig. 5-2B for location of adjustments.
- i. Set the termination slide switch to the $10\,\text{mA/mV}$ position and increase the amplitude of the pulse generator output for four divisions of deflection.
- j. CHECK—First 25 nanoseconds of step for aberrations within +4%, -4%, total of 6% (5 foot probe) or 8% (9 foot probe) peak to peak; +1%, -1%, total of 2% peak to peak thereafter (not including the effects of the test oscilloscope).

2. Check Risetime

- a. Turn the test oscilloscope sweep magnifier to $\times 10$ and position the leading edge of the display near the center of the CRT.
- b. CHECK—CRT display for risetime of \leq 2.9 nanoseconds (with Type 454 test oscilloscope operating within specification). See Fig. 5-3A.

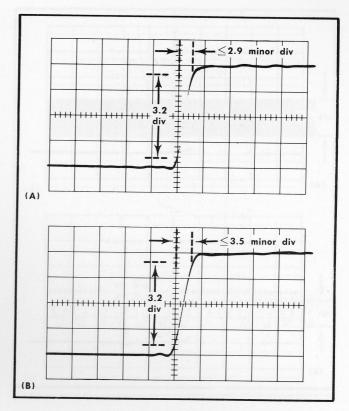


Fig. 5-3. Risetime check showing (A) 2.9 nanoseconds at 10 mA/mV, and (B) 3.5 nanoseconds at 1 mA/mV.

- c. Set the termination slide switch to the 1 mA/mV position, and adjust the amplitude of the pulse generator output for four divisions of deflection.
- d. CHECK—CRT display for risetime of \leq 3.5 nanoseconds (with Type 454 test oscilloscope operating within specification). See Fig. 5-3B.

3. Check Sensitivity

- a. Remove the P6022 Probe, Termination, and Calibration Fixture from the test equipment.
- b. Connect one 50-ohm GR $10\times$ attenuator, one 50-ohm GR $5\times$ attenuator, and a five-nanosecond length of RG 213/U cable to the output of the pulse generator.
- c. Connect the other end of the cable through a 50-ohm GR to BNC termination to the input of the test oscilloscope.
- d. Turn the sweep magnifier off and adjust the amplitude of the pulse generator output for four divisions of deflection. See Fig. 5-4A.
- e. Remove the attenuators, cable, and termination and replace with the P6022 Probe, Termination, and Calibration Fixture.
- f. CHECK—CRT display for four divisions of deflection, $\pm 3\%$ (not including GR attenuator error). See Fig. 5-4B.

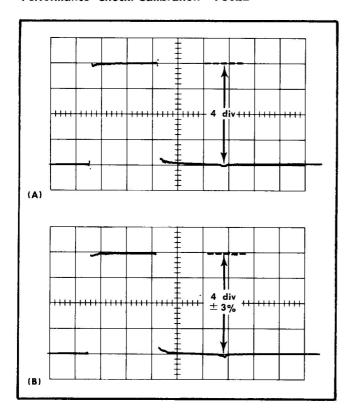


Fig. 5-4. Sensitivity check showing (A) four-division deflection from voltage source and (B) current probe and termination deflection of four divisions, \pm 3 %.

- g. Remove the P \pm 022 Probe, Termination, and Calibration Fixture from the test oscilloscope.
- h. Connect two 50-ohm GR $10\times$ attenuators, one 50-ohm GR $5\times$ attenuator, and a five-nanosecond length of RG 213/U cable to the output of the pulse generator.
- i. Connect the other end of the cable through a 50-ohm GR to BNC termination to the input of the test oscilloscope.
- j. Adjust the amplitude of the pulse generator output for four divisions of deflection. See Fig. 5-4A.

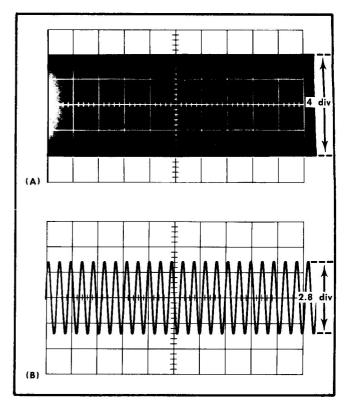


Fig. 5-5. Low-frequency response check, 1 mA/mV, showing (A) four-division, 50 kHz display, and (B) 2.8 division display.

- k. Remove the attenuators, cable, and termination and replace with the P6022 Probe, Termination, and Calibration Fixture. Set the termination slide switch to the 10 mA/mV position.
- 1. CHECK—CRT display for four divisions of deflection, $\pm 3\%$ (not including GR attenuator error). See Fig. 5-4B.

4. Check Low Frequency Response

a. Connect the banana plug to BNC adapter, the BNC to GR adapter, and the Calibration Fixture to the output of the low-frequency signal generator. Connect the P6022 Probe to the Calibration Fixture.

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- b. Set the test oscilloscope Time/Div switch to .5 mS and the termination slide switch to the 1 mA/mV position.
- c. Set the signal generator frequency to $50\,\mathrm{kHz}$ and adjust the output level for four divisions of vertical deflection. See Fig. 5-5A.
- d. Lower the frequency of the signal generator until the amplitude of the display reduces to 2.8 divisions. See Fig. 5-5B.
- e. CHECK—Signal generator frequency setting of \leq 8.5 kHz
- f. Set the test oscilloscope Time/Div switch to $2\,\text{mS}$, Volts/Div to $5\,\text{mV}$, and the termination slide switch to the $10\,\text{mA/mV}$ position.
- g. Set the signal generator frequency to 50 kHz and adjust the output level for 1.4 divisions of vertical deflection. See Fig. 5-6A.
- h. Lower the frequency of the signal generator until the amplitude of the display reduces to one division. See Fig. 5-68.
- i. CHECK—Signal generator frequency setting of \leq 935 Hz.
- j. Disconnect all test equipment and replace the termination cover.

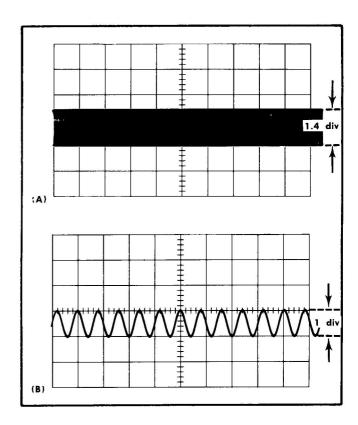
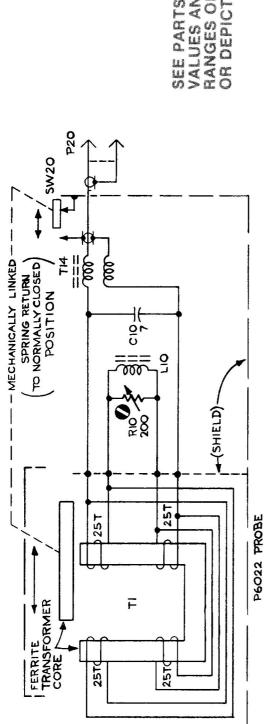
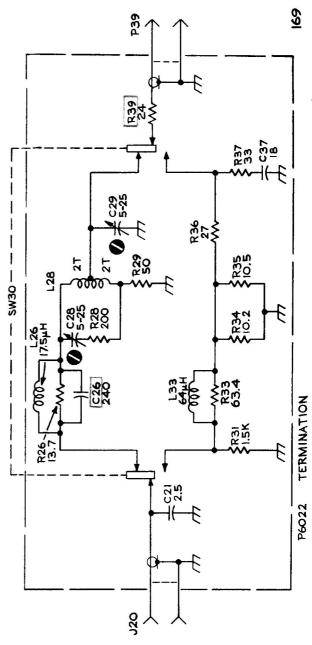


Fig. 5-6. Low-frequency response check, 10 mA/mV, showing (A) 1.4 division, 50 kHz display, and (B) one-division display.



SEE PARTS LIST FOR EARLIER VALUES AND SERIAL NUMBER RANGES OF PARTS OUTLINED OR DEPICTED IN GREY.



TYPE P6022 CURRENT PROBE & TERMINATION

SECTION 6 ELECTRICAL PARTS LIST

Values are fixed unless marked Variable.

P6022 Probe

Ckt. No.	Tektronix Part No.	Serial/Model Eff	No. Disc		Descript	ion		
Capacitor								
Tolerance ±20% unless otherwise indicated.								
C10	283-0157-00			7 pF	Cer	500 V	5%	
			Induc	for				
L10	*120-0285-00			Toroid, 4 turns s	single			
			Plug	1				
P201								
			Resist	or				
Resistors are fix	ed, composition,	±10% unless						
RIO	311-0605-00			200 Ω, Var				
Switch								
Wired or Unwired $SW20^2$								
Transformers								
T1 T14	*120-0603-00 *120-0286-00			Current Toroid, 2 turns b	oifilar			

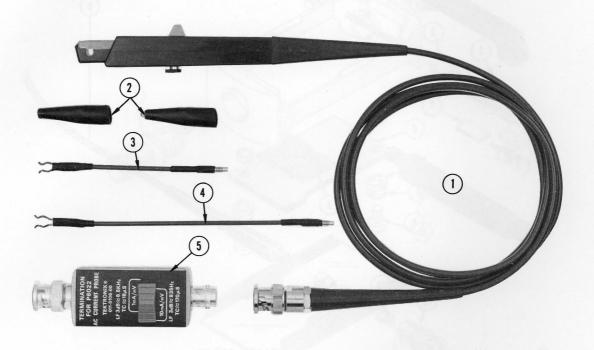
¹See Mechanical Parts List.

²See Mechanical Parts List.

P6022 Termination

Ckt. No.	Part No. Tektronix	Serial/M Eff	odel No. Disc		Descript	tion	
			Capaci	tors			
Tolerance ±2	20% unless otherw	vise indicated	d .				
C21 C26 C26 C28 C29 C37	283-0066-00 283-0047-00 281-0638-00 281-0123-00 281-0123-00 283-0159-00	7927	7926	2.5 pF 270 pF 240 pF 5-25 pF, Var 5-25 pF, Var 18 pF	Cer Cer Cer Cer Cer	200 V 500 V 500 V	5% 5% 5%
			Connec	tors			
J20 P39	131-0602-00 131-0106-02			Receptacle, elec Receptacle, elec			
			Induct	ors			
L26 L28 L33	*108-0409-00 *108-0523-00 *108-0395-00			17.5 μΗ 0.16 μΗ 64 μΗ			
			Resist	ors			
Resitsors are	fixed, composition	, ±10% ur	nless otherwise	indicated.			
R26 R28 R29 R31 R33	321-0014-00 317-0201-00 321-0751-06 321-0210-00 321-0078-00			13.7 Ω 200 Ω 50 Ω 1.5 kΩ 63.4 Ω	1/8 W 1/8 W 1/8 W 1/8 W 1/8 W	Prec Prec Prec Prec	1% 5% ¼% 1% 1%
R34 R35 R36 R37 R39	321-0002-00 321-0003-00 317-0270-00 317-0330-00 317-0360-00 317-0240-00	7927	7926	10.2 Ω 10.5 Ω 27 Ω 33 Ω 36 Ω 24 Ω	1/8 W 1/8 W 1/8 W 1/8 W 1/8 W 1/8 W	Prec Prec	1% 1% 5% 5% 5%
			Swit	ch			
SW30	Vired or Unwired 260-0723-00			Slide			

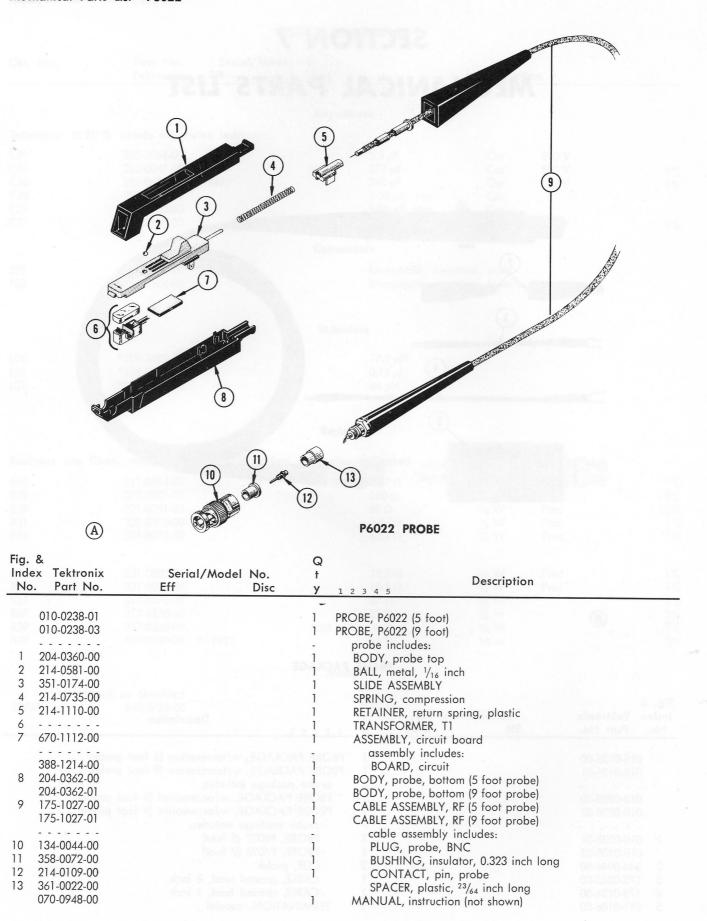
SECTION 7 MECHANICAL PARTS LIST

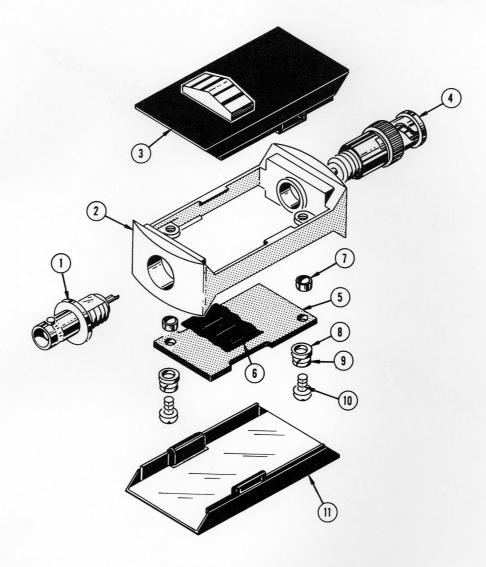




PROBE PACKAGE

nde No.	x Tektronix Part No.	Serial/Model Eff	No. Disc	t	Description
140.	Turrito.	Place III	Disc		1 2 3 4 5
	015-0135-00			1	PROBE PACKAGE, w/termination (5 foot probe)
	015-0135-01			1	PROBE PACKAGE, w/termination (9 foot probe)
				u-	probe package includes:
	010-0238-00			1	PROBE PACKAGE, w/accessories (5 foot probe)
	010-0238-02			1	PROBE PACKAGE, w/accessories (9 foot probe)
				_	probe package includes:
1	010-0238-01			1	PROBE, P6022 (5 foot)
	010-0238-03			1	PROBE, P6022 (9 foot)
2	344-0046-00			2	CLIP, probe
3	175-0263-00			1	CABLE, ground lead, 3 inch
4	175-0124-00			1	CABLE, ground lead, 5 inch
5	011-0106-00			1	TERMINATION, coaxial





P6022 TERMINATION

Fig. & Index No.	Tektronix Part No.	Serial/Model Eff	No. Disc	Q t y	Description
	011-0106-00			1	TERMINATION, P6022
					termination includes:
1	131-0106-02			1	CONNECTOR, BNC, female
2	426-0423-03			i	FRAME, termination
3	200-0852-06			i	COVER, termination, w/knob
4	131-0602-00			i	CONNECTOR, electrical, male
5	670-1053-00			i	ASSEMBLY, circuit board
					assembly includes:
6	214-1108-00			1	INSULATOR, plate
	388-1213-00			i	BOARD, circuit
					mounting hardware: (not included w/assembly)
7	361-0219-00			2	SPACER, sleeve, 0.087 ID x 0.187 inch OD
8	210-1008-00			2	WASHER, flat, 0.090 ID x 0.188 inch OD
9	210-0053-00			2	LOCKWASHER, split, #2
10	211-0001-00			2	SCREW, 2-56 x 1/4 inch, RHS
11	200-0851-03			1	COVER, termination

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